

Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/719,090	LEE, CHANG-JUNG	
Examiner	Art Unit	
Trinh Vo Dinh	2821	

SEARCHED

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

INTERFERENCE SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner